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Description

This invention relates to incubators, particularly those used in analyzers to assay for analytes in liquids.

Certain analyzer incubators, such as those described in US-A-4298571, comprise a rotor which is an annular disk having a lower support surface for test elements and an evaporation cover at each station around the circumference of the disk. (The specific incubator shown in US-A-4298571 is for potentiometric test elements, but a similar one has been used for colorimetric test elements in commercial instruments.) The entire disk is cast as a single piece, necessitating castings of the finest quality, in order to ensure that each support surface (for each test element) is flat and at a predictable height in the "Z" dimension. In particular, little or no warpage can be tolerated. The reason for the strict control of height tolerances is that for some incubators, the test elements held on such support surfaces, are read, in place, at the respective incubator station by a built-in reflectometer. This is particularly the case for incubators requiring multiple readings of the same test elements (the so-called "rate" test elements). Any variation in height (the "Z" dimension) of the support surface away from its predictable location, called a "precessing" error due to the disc wobbling as it rotates, alters the amount of light falling onto the test element from the reflectometer. This in turn creates an error in the colorimetric reading.

It is known that rate test elements are read at the first derivative level, so that errors introduced into the absolute readings disappear. However, some test elements are colorimetrically read only at their end point. If the same incubator is to be used for both rate test elements and such end-point elements, a desired goal to simplify analyzers, an improvement is needed in the rotor to avoid the noted precessing error.

Not only does such needed accuracy in reading cause manufacturing problems in making such rotors, but in addition, the rotors are very expensive. This leads to a substantial loss if such rotors are defective or break for any reason.

Yet another drawback with the rotors described in US-A-4298571 is that the test element holding means is not readily removable from the rotor, due to the manner in which the hold-down spring is attached.

There has been a need, therefore, prior to this invention, to provide an incubator in which the rotor provides support surfaces that more readily ensure a predictable height of test elements from the surface on which the rotor rotates, without requiring careful production of the entire rotor; or a more readily removable test element holding means.

One solution to this problem has been to provide a rotor which has no supporting surface underneath the test elements. In such a rotor, test elements are

pushed around directly on a stationary incubator surface. Examples of such rotors are described in Japanese Kokai 86/259142. For low through-put volumes, such is not a problem. However, high through-put analyzers rotate the rotors very rapidly, with considerable acceleration. If, as is common, the test element is manufactured from a plastic material such as polystyrene which does not wear well, there is considerable polystyrene dust created which jams up the incubator, requiring repeated cleaning.

Yet another problem with conventional rotors has been that the spring used to hold test elements in the rotor has been somewhat difficult to assemble and remove.

Thus, the need for an improved rotor has remained unmet, at least regarding high through-put analyzers. (As used herein, high through-put means at least 200 test elements per hour.)

It is an object of the present invention to provide an incubator which is useful for high through-put analyzers which avoids the need for expensive lower supports in the rotor.

More specifically, in accordance with one aspect of the present invention, there is provided an incubator for use in an analyzer comprising:

a stationary surface above which test elements are moved while being held in assigned test element stations;

a rotor including holding means for holding test elements at the stations, the holding means including a lower support mounted to slide above the stationary surface and a cover member, a test element being sandwichable between the lower support and the cover member;

rotation means for rotating the rotor about an axis which includes drive means and connecting means for connecting the rotor to the drive means, the connecting means including bearing means for providing relative rotation between the rotor and the stationary surface; and

reading means fixed in the incubator for scanning a test element held in the holding means, at least the lower support being apertured to allow a scanning beam to pass through to a test element held by the holding means;

characterized in that the stationary surface includes three reference surfaces which comprise a fraction of the stationary surface and are positioned at a predetermined distance along the axis, one of the reference surfaces being circumferentially positioned adjacent the scanning beam to ensure proper reading distance for test elements as they are read by the reading means, the lower support being mounted so as to movably bear on the reference surfaces.

It is an advantageous feature of this invention that an incubator is provided with an inexpensive rotor for high through-put, which automatically corrects for precessing errors without necessitating careful rotor

manufacturing.

Another advantageous feature is the use of element holding means which are readily removable from the incubator.

The present invention will now be described by way of example only, with reference to the accompanying drawings in which:

Figure 1 is a fragmentary elevational view in section of an incubator constructed in accordance with the prior art;

Figure 2 is an elevational view similar to that shown in Figure 1, but illustrating the modification provided by the present invention;

Figure 3 is a fragmentary plan view of a stationary lower surface of the incubator illustrating preferred spacing of reference surfaces;

Figure 4 is an elevational view similar to that shown in Figure 2, but illustrating an alternate embodiment;

Figure 5 is an enlarged fragmentary plan view similar to that shown in Figure 3, but corresponding to the embodiment shown in Figure 4;

Figure 6 is an elevational view similar to that shown in Figure 4, but illustrating a further embodiment;

Figure 7 is a plan view of a spring, cover member and lower support member of test element holding means; and

Figure 8 is a sectioned view taken generally along the line VIII-VIII of Figure 7, and includes the stationary surface of the incubator.

The invention is described in connection with certain preferred embodiments wherein the incubator has a rotor constructed with various features, as part of a blood analyzer, to allow a test element to be read with a light beam while in the incubator. In addition the invention is useful in any high through-put incubator, whether it is an integral part of an analyzer or not, using a light beam or not, and regardless of the liquid being analyzed, wherein that incubator necessitates precise positioning of the held test element along the "Z" axis, that is, along the axis of rotation of the rotor.

Parts and relative positions that are described as being "above", "up" or "down", and the like, refer to orientation and positions which occur during normal use of apparatus according to the invention.

In Figure 1, an incubator 22 constructed according to the prior art is shown. This incubator is used in analyzers such as those described in US-A-4298571. The incubator 22 includes a carefully crafted rotor 24 which has a precisely machined lower support 26 which supports a test element E thereon at a station such as that indicated by arrow 'A'. A cover 28 is releasably pressed onto the test element by biasing means such as leaf spring 30, held in the rotor. Body 32 of the rotor includes a ring gear 34 that meshes with, and is driven by, a gear 36 on a drive shaft 38. Body 32 rotates about a vertical ("Z") axis 40, by

means of a bearing 42 that is fixed along axis 40 by way of a shoulder portion 44 formed in body 32 and a surface 46 formed in a stationary frame 47 of the incubator 22. The lower support 26 is then caused to rotate or slide above surface 46 of the incubator 22. The surface 46 and upper stationary surface 48 act to control the temperature of the incubator, as is conventional.

It will be readily appreciated that such a construction requires exact tolerances in the shape of lower support 26, as otherwise it will not be perfectly flat, and will wobble or precess as it turns about axis 40. For uses in which a precise location of a test element E along axis 40 is required, such wobble or precessing error is unacceptable.

In accordance with the invention, the precessing error is eliminated without the need for careful rotor tolerances as described with reference to Figures 2 and 3.

Incubator 62 is constructed in a manner similar to that illustrated in Figure 1, namely, to receive and hold colorimetric test elements in a controlled environment at stations such as station A. (As in Figure 1, means for loading the test elements into the incubator are known, and have been omitted for clarity.) Thus incubator 62 comprises a rotor 64 having a lower rotating support 66 on which test elements E rest, and covers 68 are spring-biased against elements E by leaf springs 70 attached at their inner ends 71 to the rotor body 72. Body 72 is driven by gear 76 and motor 78 which drives a ring gear 74, the rotor 64 rotating about the "Z" axis 80. A bearing 82 permits rotation of body 72 relative to stationary frame member 87.

In order to allow colorimetric elements E to be read while sandwiched between lower support 66 and cover 68 of rotor 64, a read station 90 is provided. This station 90 is fixed relative to lower surface 86 of the incubator, for example, below it as shown. The station 90 includes a light source 92, and apertures 94 and 96 through lower surface 86 and lower support 66 respectively, to allow a light beam 100 to impinge on element E, as is known. Aperture 96 is also shaped to allow a reflected beam 102 to pass to a detector, not shown, at a different angle than beam 100 (for example, 45° and 90° respectively, to the surface of element E.)

The control of the position of the test element E along the "Z" axis 80 is done, not by fixing the location of bearing 82, but rather by providing three reference surfaces 110, 110' on stationary surface 86, as shown more clearly in Figure 3. One surface 110' is closely adjacent to aperture 94. Each surface 110, 110' is a bearing surface, against which lower element support 66 slides as the rotor rotates. Surfaces 110, 110' are thus precisely fixed a predetermined distance along axis 80, so as to similarly fix such "Z" axis distance of a test element that passes through light beam 100. (Three surfaces 110, 110' are needed

to define a plane.) Because the test element's distance from the read station is thus fixed, bearing 82 fixed to the rotor, is allowed to float vertically on a vertical race 112. Furthermore, lower element support 66 can be manufactured without regard to warpage or not, since it can precess freely as it passes above surface 86 until it makes contact with the reference surfaces 110. In this invention, the thickness of support 66 still needs to be controlled, but this is far easier than controlling overall warpage of support 66.

Preferably, reference surfaces 110 and 110' comprise a pad of a low friction material, such as acetal or nylon materials, and together are less than 5% of the total surface area of surface 86. Most preferably, as shown in Figure 3, reference surfaces 110 and 110' are equally spaced around the circumference of surface 86, each with a diameter "d" of about 9mm, that is, their angular spacing around axis 80 is at generally equal values of α ($\approx 120^\circ$).

To hold each reference surface 110 and 110' in replaceable position, holes 120 are preferably formed in surface 86, into which the pads are inserted.

In other embodiments, the driving mechanism for the rotor can be mounted inside body 72, as shown in Figure 4. Parts similar to those previously described bear the same reference numeral, to which the distinguishing suffix "A" is appended. Thus, as in the embodiment of Figure 4, incubator 62A comprises a rotor 64A which has a lower element support 66A, a cover 68A and a leaf spring 70A releasably pressing cover 68A down onto the test element. Lower support 66A is apertured at 96A to pass a light beam 100A from a light source 92A, and a reflected beam 102A. Rotor body 72A is journaled via bearing 82A which floats vertically on frame 87A. A pin 140 is shown as locating cover 68A relative to spring 70A. As before, reference surface 110'A is located closely adjacent to aperture 96A. A highly preferred construction is one in which the radial distance "X" of surface 110'A measured from where opening 96A passes thereabove approaches zero, as shown in Figure 5. Most preferably, opening 96A traces an arc which is tangential to the circumference of the pad of surface 110'A.

The rotor need not have the configuration shown in Figures 2 and 4, but can have a variety of constructions. Further constructions are shown in Figures 6 to 8. Parts similar to those previously described bear the same reference numeral to which the distinguishing suffix "B" is appended.

Thus, incubator 62B comprises, as before, a rotor 64B which includes a lower support 66B, a cover member 68B and a spring 70B biasing member 68B towards support 66B with a spring force F, to hold a test element E between the two. (Element E is shown as it is being fed in between member 68B and support 66B against the spring force F.) Lower support 66B is,

as already described, a ring. In this embodiment it is attached by suitable means such as a screw 200, to a flange 202 of rotor 64B. The ring of support 66B slides against three stationary reference pads 110B, 110'B (only one shown) of which pad 110'B is adjacent to a read aperture 94B in stationary surface 86B, and to read aperture 96B in support 66B.

However, unlike the previous embodiments, spring 70B is a leaf spring mounted so as to be releasably captured or sandwiched between an upper rotor portion 210 which extends out over much of station A and the spring 70B. Preferably, spring 70B comprises three portions 220, 224 and 240, as shown in Figures 7 and 8.

Portion 220 is a body portion which bears directly onto cover member 68B, specifically a boss 222 thereof (Figure 8), which has a pin 223 to penetrate portion 220 of spring 70B. Portion 224 is a biasing leg which is stamped out of portion 220 to releasably fit against portion 210 of rotor 64B, and is snapped in place behind a ledge 228 of portion 210. Leg 224 also biases body portion 220 downward. An aperture 230 is formed in portion 210 (Figure 6) to allow operator access to flange 224 to depress it to allow the assembly of spring 70B, cover member 68B, and support member 66B to be slid out of the rotor for cleaning and the like. Portion 240 of spring 70B comprises a rear leg which presses against support member 66B. Preferably, both the front and the rear of cover member 68B have a foot 242 at each corner (Figures 6 and 8) to raise the cover slightly above an incoming element E, whereby any liquid L (Figure 6) is not wiped against the cover member.

To drive rotor 64B, gear teeth 260 can be mounted on portion 210, and the rotor is freely journaled at bearing 262 for rotation about a fixed shaft 264. Teeth 260 are engaged by any suitable drive means, not shown, for example, a driven pulley or a gear. Alternatively, portion 210 can be smooth and a belt engages it by friction.

Bearing 262 can be biased downwardly against a conical capture sleeve 263, by means of a compression spring 265 held in place by pin 267. This bias ensures that support member 66B will press against pads 110, 110'B.

Optionally, a conventional sensor is mounted at 270 to detect flags 272 on rotor 64B, as a means for sensing which station, such as station A, is at the read station comprising apertures 94B and 96B, and a reflectometer (not shown).

Also optionally, rotor 64B can have vertical reinforcing splines 280 connecting the portions 210 of the rotor in between each of the stations.

Claims

1. An incubator for use in an analyzer comprising:

a stationary surface (86; 86A; 86B) above which test elements (E) are moved while being held in assigned test element stations;

a rotor (64; 64A; 64B) including holding means (66, 68, 70; 66A, 68A, 70A; 66B, 68B, 70B) for holding test elements (E) at the stations, the holding means (66, 68, 70; 66A, 68A, 70A; 66B, 68B, 70B) including a lower support (66; 66A; 66B) mounted to slide above the stationary surface (86; 86A; 86B) and a cover member (68; 68A; 68B), a test element (E) being sandwichable between the lower support (66; 66A; 66B) and the cover member (68; 68A; 68B);

rotation means (74, 76, 78; 74A, 76A, 78A; 260) for rotating the rotor (64; 64A; 64B) about an axis (80; 80A) which includes drive means (78; 78A) and connecting means (74, 76; 74A, 76A; 260) for connecting the rotor (64; 64A; 64B) to the drive means (78; 78A), the connecting means (74, 76; 74A, 76A; 260) including bearing means (82; 82A; 262) for providing relative rotation between the rotor (64; 64A; 64B) and the stationary surface (86; 86A; 86B); and

reading means (90; 90A) fixed in the incubator for scanning a test element (E) held in the holding means (66, 68, 70; 66A, 68A, 70A; 66B, 68B, 70B), at least the lower support (66; 66A; 66B) being apertured to allow a scanning beam (100; 100A) to pass through to a test element (E) held by the holding means (66, 68, 70; 66A, 68A, 70A; 66B, 68B, 70B);

characterized in that the stationary surface (86; 86A; 86B) includes three reference surfaces (110, 110'; 110A, 110'A; 110B, 110'B) which comprise a fraction of the stationary surface (86; 86A; 86B) and are positioned at a predetermined distance along the axis (80; 80A), one of the reference surfaces (110'; 110'A; 110'B) being circumferentially positioned adjacent the scanning beam (100; 100A) to ensure proper reading distance for test elements (E) as they are read by the reading means (90; 90A), the lower support (66; 66A; 66B) being mounted so as to movably bear on the reference surfaces (110, 110'; 110A, 110'A; 110B, 110'B).

2. An incubator according to claim 1, wherein the bearing means (82; 82A; 262) is free to move in a direction parallel to the axis (80; 80A) so that the reference surfaces (110, 110'; 110A, 110'A; 110B, 110'B) and not the bearing means (82; 82A; 262) determine the distance along the axis (80; 80A) of test elements (E) held by the holding means (66, 68, 70; 66A, 68A, 70A; 66B, 68B, 70B) at the reading means (90; 90A).
3. An incubator according to claim 1, wherein the three reference surfaces (110, 110'; 110A, 110'A;

110B, 110'B) are equispaced around the circumference of the stationary surface (86; 86A; 86B).

4. An incubator according to claim 2 or 3, wherein the reference surfaces (110, 110'; 110A, 110'A; 110B, 110'B) comprise pads of low friction material, replacably mounted in holes (120) in the stationary surface (86; 86A; 86B).
5. An incubator according to any one of the preceding claims, wherein the rotor (64; 64A; 64B) includes a spring (70; 70A; 70B) which biases the cover member (68; 68A; 68B) towards the lower support (66; 66A; 66B).
6. An incubator according to claim 5, wherein the spring is a leaf spring (70B) having a body portion (220) releasibly pressed against the cover member (68; 68A; 68B), and two leg portions (224, 240) which extend from the body portion (220).
7. An incubator according to claim 6, wherein the rotor (64B) includes a ledge (228) and one of the leg portions (224) is constructed to releasibly snap in place relative to the ledge (228) so that the spring (70B) is captured by the rotor (64B).
8. An incubator according to claim 7, wherein the other of the leg portions (240) is releasibly pressed against the lower support (68B).

Patentansprüche

1. Inkubator zur Verwendung in einem Analysegerät mit
 - einer stationären Fläche (86; 86A; 86B), oberhalb welcher Testelemente (E) in Zuordnung zu Teststationen bewegt werden;
 - einem Rotor (64; 64A; 64B) mit Haltemitteln (66, 68, 70; 66A, 68A, 70A; 66B, 68B, 70B) zum Haltern der Testelemente (E) in den Teststationen, wobei die Haltemittel einen über der stationären Fläche (86; 86A; 86B) gleitenden unteren Träger (66; 66A; 66B) und ein Abdeckteil (68; 68A; 68B) aufweisen, und wobei zwischen dem unteren Träger (66, 66A; 66B) und dem Abdeckteil (68; 68A; 68B) ein Testelement (E) aufgenommen werden kann;
 - Drehantriebsmitteln (74, 76, 78; 74A, 76A, 78A, 260) zum Drehen des Rotors (64; 64A; 64B) um eine Achse (80; 80A), die Antriebsmittel (78; 78A) aufweist sowie Verbindungsmittel (74, 76; 74A, 76A; 260) zum Verbinden des Rotors (64; 64A; 64B) mit den Antriebsmitteln (78; 78A), wobei die Verbindungsmittel (74, 76; 74A, 76A; 260)

- ein Lager (82; 82A; 262) aufweisen, das eine Drehung des Rotors (64; 64A; 64B) relativ zur stationären Fläche (86; 86A; 86B) ermöglicht; und
- einer im Inkubator angeordneten Einrichtung (90; 90A) zum optischen Abtasten eines von den Haltemitteln (66, 68, 70; 66A, 68A, 70A; 66B, 68B, 70B) gehaltenen Testelements (E), wobei mindestens der untere Träger (66; 66A; 66B) mit einer Öffnung versehen ist, durch die ein Abtaststrahl (100; 100A) ein von den Haltemitteln gehaltenes Testelement (E) erreichen kann;
- dadurch gekennzeichnet, daß die stationäre Fläche (86; 86A; 86B) drei Bezugsflächen (110, 110'; 110A, 110'A; 110B, 110'B) aufweist, die einen Teilbereich der stationären Fläche bilden und in vorgegebenem Abstand in Richtung der Achse (80, 80A) angeordnet sind, wobei eine der auf einer Kreislinie verteilt angeordneten Bezugsflächen (110, 110'; 110A, 110'A; 110B, 110'B) dem Abtaststrahl (100; 100A) benachbart ist, um einen für die Abtastung durch die Einrichtung (90; 90A) erforderlichen Sollabstand der Testelemente sicherzustellen, und wobei der untere Träger (66; 66A; 66B) so angeordnet ist, daß er sich bewegbar auf den Bezugsflächen (110, 110'; 110A, 110'A; 110B, 110'B) abstützt.
2. Inkubator nach Anspruch 1, dadurch gekennzeichnet, daß das Lager (82; 82A; 262) parallel zur Achse (80; 80A) bewegbar ist, so daß ausschließlich die Bezugsflächen (110, 110'; 110A, 110'A; 110B, 110'B) den Abstand der von den Haltemitteln (66, 68, 70; 66A, 68A, 70A; 66B, 68B, 70B) gehaltenen Testelemente (E) zur Einrichtung (90; 90A) bestimmen.
 3. Inkubator nach Anspruch 1, dadurch gekennzeichnet, daß die drei Bezugsflächen (110, 110'; 110A, 110'A; 110B, 110'B) gleichmäßig über den Umfang der stationären Fläche (86; 86A; 86B) verteilt sind.
 4. Inkubator nach Anspruch 2 oder 3, dadurch gekennzeichnet, daß die Bezugsflächen (110, 110'; 110A, 110'A; 110B, 110'B) Stützelemente aus reibungsarmem Material umfassen, die in Aussparungen (120) in der stationären Fläche (86; 86A; 86B) austauschbar angeordnet sind.
 5. Inkubator nach einem der vorhergehenden Ansprüche, dadurch gekennzeichnet, daß der Rotor (64; 64A; 64B) eine Feder (70; 70A; 70B) aufweist, die das Abdeckteil (68; 68A; 68B) gegen den unteren Träger (66; 66A; 66B) drückt.

6. Inkubator nach Anspruch 5, dadurch gekennzeichnet, daß die Feder eine Blattfeder (70B) ist, die aus einem lösbar gegen das Abdeckteil (68; 68A; 68B) gedrückten Hauptteil (220) und zwei Schenkeln (224, 240) besteht, die vom Hauptteil ausgehen.
7. Inkubator nach Anspruch 6, dadurch gekennzeichnet, daß der Rotor (64B) eine Leiste (228) aufweist und einer der Blattfederschinkel (224) so ausgebildet ist, daß er an der Leiste (228) lösbar einrastet, damit die Feder (70B) fest mit dem Rotor (64B) verbunden ist.
8. Inkubator nach Anspruch 7, dadurch gekennzeichnet, daß der andere Blattfederschinkel (240) lösbar gegen den unteren Träger (68B) gedrückt wird.

Revendications

1. Incubateur destiné à être utilisé dans un analyseur, comprenant :
 - une surface fixe (86 ; 86A ; 86B) au-dessus de laquelle des éléments d'essai (E) sont déplacés lorsqu'ils sont maintenus à des postes affectés d'éléments d'essai,
 - un rotor (64 ; 64A ; 64B) comprenant un dispositif de maintien (66, 68, 70 ; 66A, 68A, 70A ; 66B, 68B, 70B) destiné à supporter les éléments d'essai (E) auxdits postes, le dispositif de maintien comprenant un support inférieur (66 ; 66A ; 66B) monté afin qu'il puisse glisser au-dessus de la surface fixe (86 ; 86A ; 86B) et un organe de couvercle (68 ; 68A ; 68B), un élément d'essai (E) pouvant être disposé entre le support inférieur (66 ; 66A ; 66B) et l'organe de couvercle (68 ; 68A ; 68B),
 - un dispositif de rotation (74, 76, 78 ; 74A, 76A, 78A ; 260) destiné à faire tourner le rotor (64, 64A ; 64B) autour d'un axe (80 ; 80A) qui comprend un dispositif d'entraînement (78 ; 78A) et un dispositif de raccordement (74, 76 ; 74A, 76A ; 260) destiné à raccorder le rotor (64 ; 64A ; 64B) au dispositif d'entraînement (78 ; 78A), le dispositif de raccordement (74, 76 ; 74A, 76A ; 260) comprenant un dispositif à palier (82 ; 82A ; 262) destiné à assurer la rotation relative entre le rotor (64 ; 64A ; 64B) et la surface fixe (86 ; 86A ; 86B), et
 - un dispositif de lecture (90 ; 90A) fixé dans l'incubateur afin qu'il analyse un élément d'essai (E) maintenu par le dispositif de maintien (66, 68, 70 ; 66A, 68A, 70A ; 66B, 68B, 70B), le support inférieur au moins (66 ; 66A ; 66B) ayant des orifices permettant le passage d'un faisceau de balayage (100 ; 100A) à travers un élément

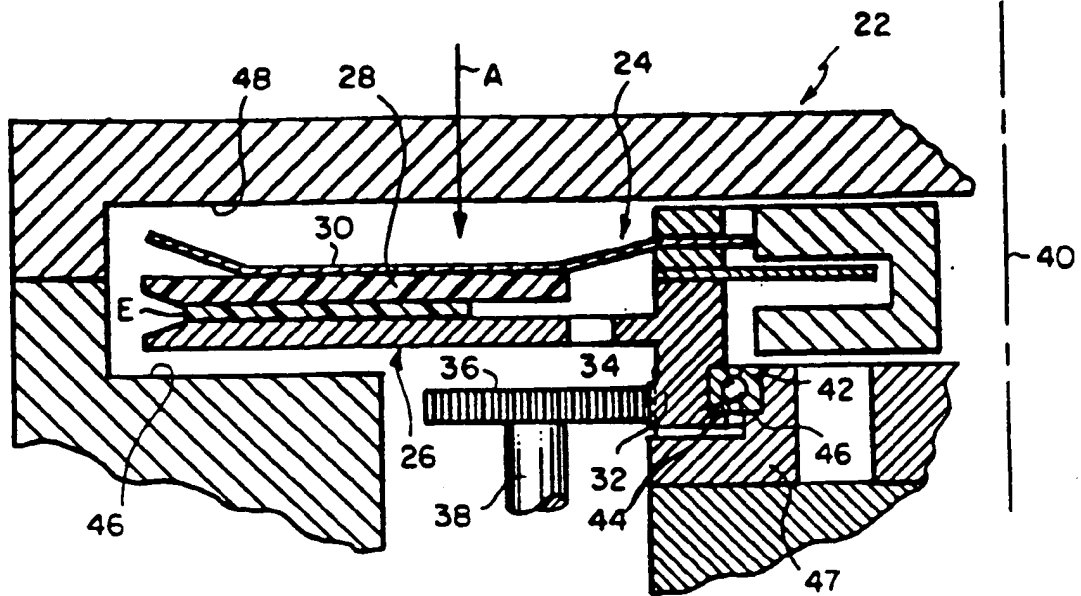
d'essai (E) supporté par le dispositif de maintien (66, 68, 70 ; 66A, 68A, 70A ; 66B, 68B, 70B),

caractérisé en ce que la surface fixe (86 ; 86A ; 86B) comporte trois surfaces de référence (110, 110' ; 110A, 110'A ; 110B, 110'B) qui forment une fraction de la surface fixe (86 ; 86A ; 86B) et qui sont placées à une distance prédéterminée le long de l'axe (80 ; 80A), l'une des surfaces de référence (110' ; 110'A ; 110'B) étant positionnée circonférentiellement près du faisceau de balayage (100 ; 100A) de manière qu'une distance convenable de lecture des éléments d'essai (E) soit obtenue lors de leur lecture par le dispositif de lecture (90 ; 90A), le support inférieur (66 ; 66A ; 66B) étant monté afin qu'il supporte les surfaces de référence (110, 110' ; 110A, 110'A ; ; 110B, 110'B) afin qu'elles soient mobiles.

2. Incubateur selon la revendication 1, dans lequel le dispositif à palier (82 ; 82A ; 262) est libre de se déplacer en direction parallèle à l'axe (80 ; 80A) si bien que ce sont les surfaces de référence (110, 110' ; 110A, 110'A ; 110B, 110'B) et non les dispositifs à palier (82 ; 82A ; 262) qui déterminent la distance le long de l'axe (80 ; 80A) des éléments d'essai (E) portés par le dispositif de maintien (66, 68, 70 ; 66A, 68A, 70A ; 66B, 68B, 70B) au niveau du dispositif de lecture (90 ; 90A).
3. Incubateur selon la revendication 1, dans lequel les trois surfaces de référence (110, 110' ; 110A, 110'A ; 110B, 110'B) sont régulièrement espacées à la circonférence de la surface fixe (86 ; 86A ; 86B).
4. Incubateur selon la revendication 2 ou 3, dans lequel les surfaces de référence (110, 110' ; 110A, 110'A ; 110B, 110'B) comprennent des patins d'une matière à faible coefficient de frottement, montés de façon remplaçable dans des trous (120) de la surface fixe (86 ; 86A ; 86B).
5. Incubateur selon l'une quelconque des revendications précédentes, dans lequel le rotor (64 ; 64A ; 64B) comporte un ressort (70 ; 70A ; 70B) qui rappelle l'organe de couvercle (68 ; 68A ; 68B) vers le support inférieur (66 ; 66A ; 66B).
6. Incubateur selon la revendication 5, dans lequel le ressort est un ressort à lame (70B) ayant une partie de corps (220) repoussée temporairement contre l'organe de couvercle (68 ; 68A ; 68B), et deux parties de branche (224, 240) qui dépassent de la partie de corps (220).
7. Incubateur selon la revendication 6, dans lequel le rotor (64B) comprend un rebord (228) et l'une

des parties de branche (224) est construite afin qu'elle s'enclenche élastiquement temporairement en place par rapport au rebord (228), si bien que le ressort (70B) est retenu par le rotor (64B).

8. Incubateur selon la revendication 7, dans lequel l'autre des parties de branche (240) est repoussée temporairement contre le support inférieur (68B).



PRIOR ART

FIG. 1

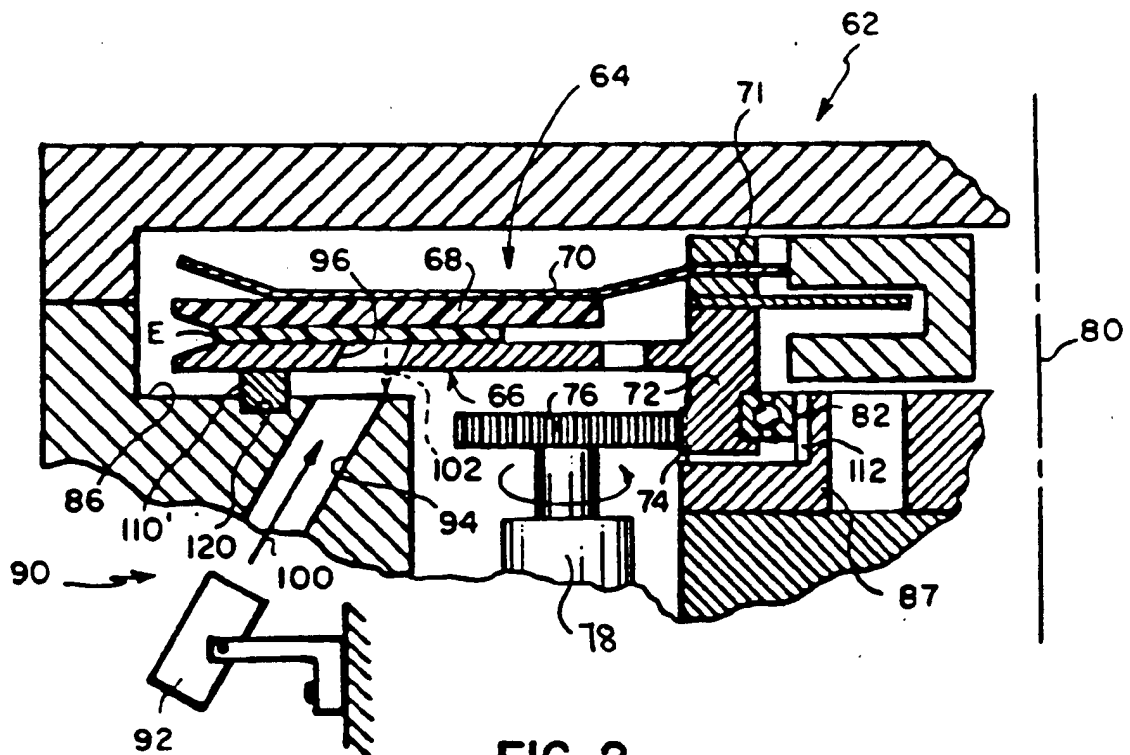


FIG. 2

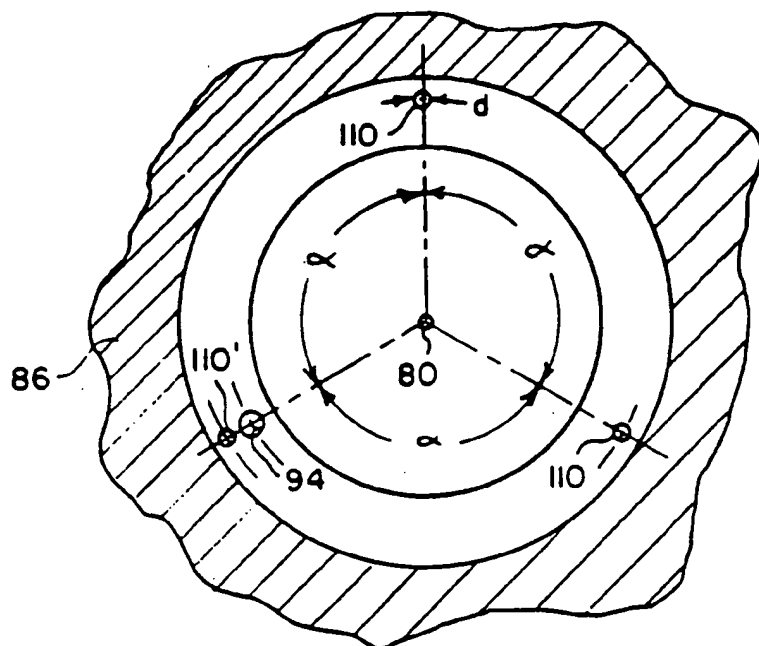


FIG. 3

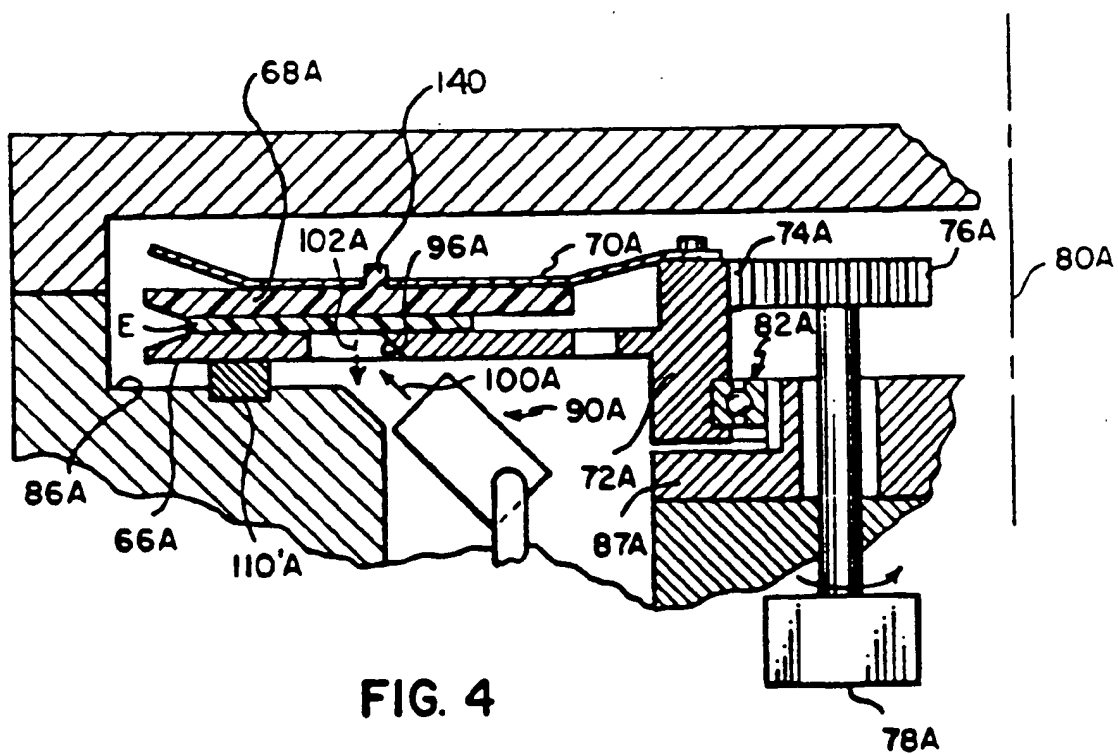


FIG. 4

FIG. 6

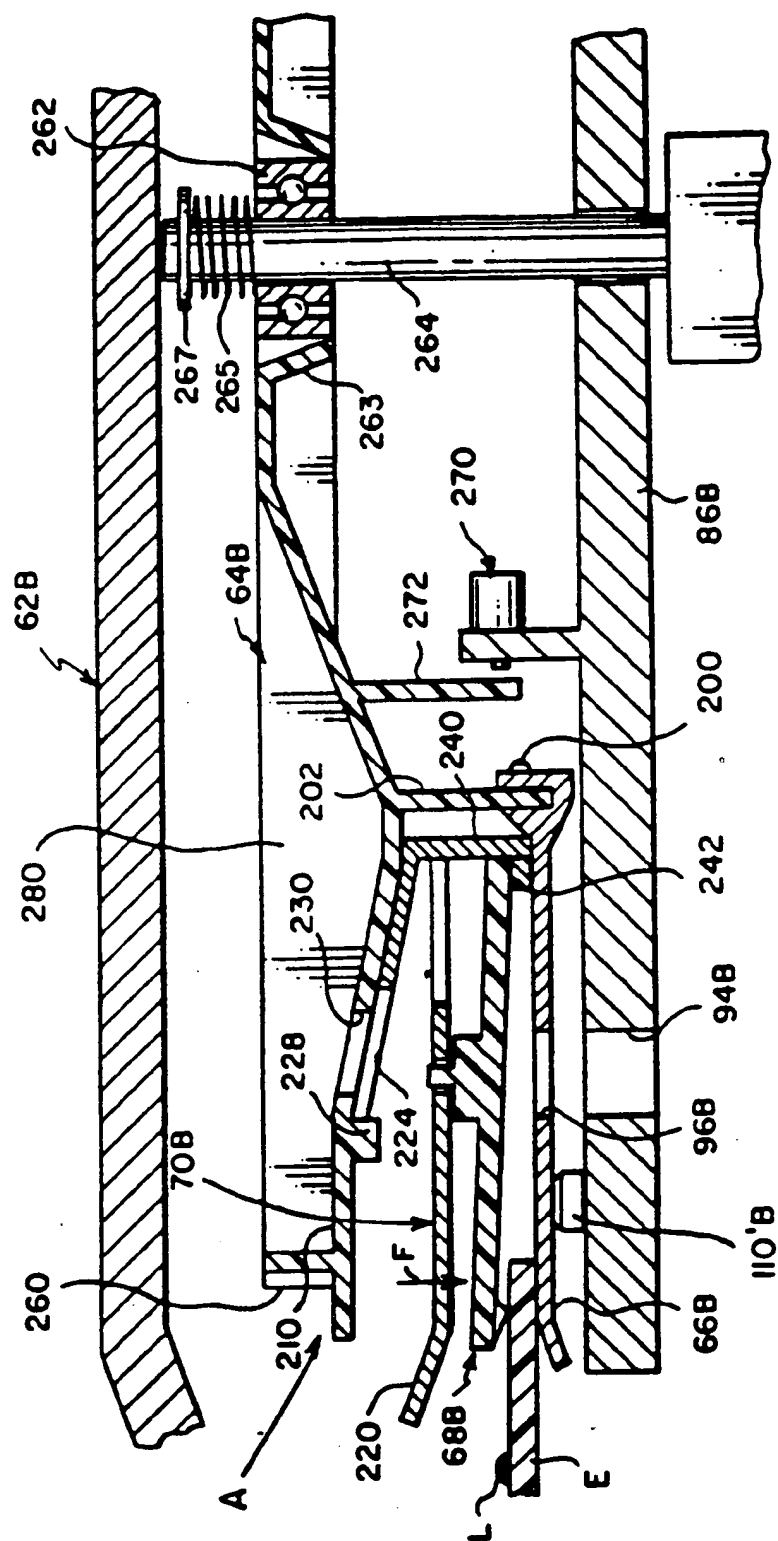


FIG. 5

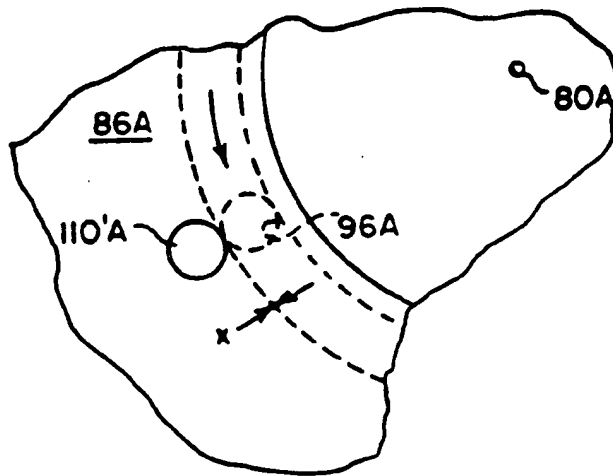


FIG. 7

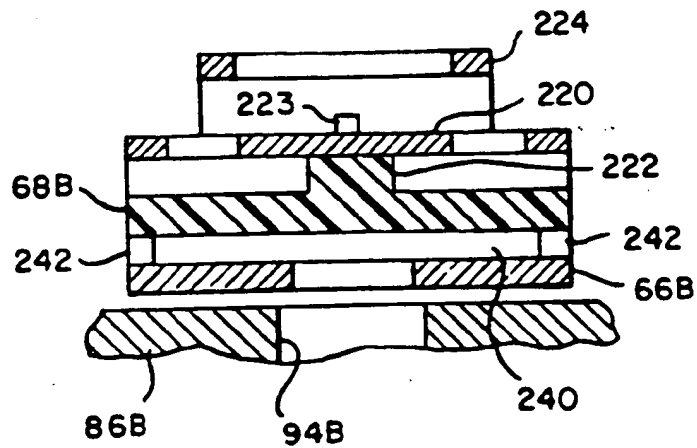
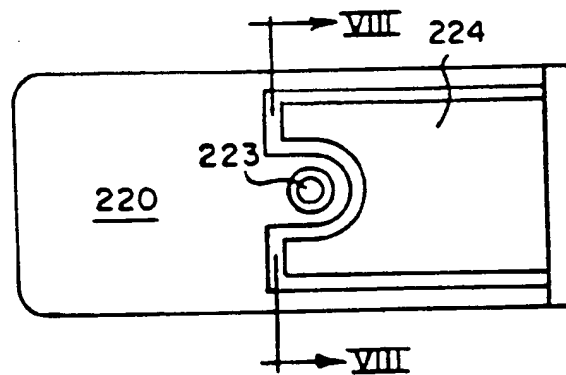


FIG. 8